

General Description

SFGMOS[®] MOSFET is based on Oriental Semiconductor's unique device design to achieve low $R_{DS(ON)}$, low gate charge, fast switching and excellent avalanche characteristics. The high V_{th} series is specially optimized for high systems with gate driving voltage greater than 10V.

Features

- Low $R_{DS(ON)}$ & FOM
- Extremely low switching loss
- Excellent stability and uniformity
- Fast switching and soft recovery



Applications

- Switched mode power supply
- Motor driver
- Battery protection
- DC-DC convertor
- Solar inverter
- UPS and energy inverter

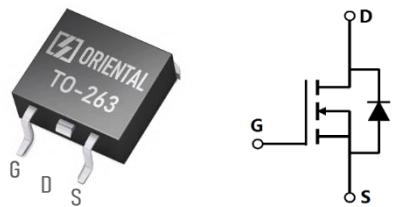
Key Performance Parameters

| Parameter | Value | Unit |
|--------------------------------|-------|------|
| $V_{DS, min} @ T_{j(max)}$ | 100 | V |
| $I_D, pulse$ | 450 | A |
| $R_{DS(ON), max} @ V_{GS}=10V$ | 3.5 | mΩ |
| Q_g | 87.8 | nC |

Marking Information

| Product Name | Package | Marking |
|--------------|---------|------------|
| SFG150N10KF | TO263 | SFG150N10K |

Package & Pin information



Absolute Maximum Ratings at $T_j=25^\circ\text{C}$ unless otherwise noted

| Parameter | Symbol | Value | Unit |
|-------------------------------------------------------------------------|----------------------|------------|------------------|
| Drain source voltage | V_{DS} | 100 | V |
| Gate source voltage | V_{GS} | ± 20 | V |
| Continuous drain current ¹⁾ , $T_C=25^\circ\text{C}$ | I_D | 150 | A |
| Pulsed drain current ²⁾ , $T_C=25^\circ\text{C}$ | $I_{D,\text{pulse}}$ | 450 | A |
| Continuous diode forward current ¹⁾ , $T_C=25^\circ\text{C}$ | I_S | 150 | A |
| Diode pulsed current ²⁾ , $T_C=25^\circ\text{C}$ | $I_{S,\text{pulse}}$ | 450 | A |
| Power dissipation ³⁾ , $T_C=25^\circ\text{C}$ | P_D | 250 | W |
| Single pulsed avalanche energy ⁵⁾ | E_{AS} | 265 | mJ |
| Operation and storage temperature | T_{stg}, T_j | -55 to 150 | $^\circ\text{C}$ |

Thermal Characteristics

| Parameter | Symbol | Value | Unit |
|----------------------------------------------------|-----------------|-------|---------------------------|
| Thermal resistance, junction-case | $R_{\theta JC}$ | 0.5 | $^\circ\text{C}/\text{W}$ |
| Thermal resistance, junction-ambient ⁴⁾ | $R_{\theta JA}$ | 62 | $^\circ\text{C}/\text{W}$ |

Electrical Characteristics at $T_j=25^\circ\text{C}$ unless otherwise specified

| Parameter | Symbol | Min. | Typ. | Max. | Unit | Test condition |
|----------------------------------|---------------------|------|------|------|------------------|--------------------------------------------|
| Drain-source breakdown voltage | BV_{DSS} | 100 | | | V | $V_{GS}=0 \text{ V}, I_D=250 \mu\text{A}$ |
| Gate threshold voltage | $V_{GS(\text{th})}$ | 2.0 | | 4.0 | V | $V_{DS}=V_{GS}, I_D=250 \mu\text{A}$ |
| Drain-source on-state resistance | $R_{DS(\text{ON})}$ | | 3.22 | 3.50 | $\text{m}\Omega$ | $V_{GS}=10 \text{ V}, I_D=30 \text{ A}$ |
| Gate-source leakage current | I_{GSS} | | | 100 | nA | $V_{GS}=20 \text{ V}$ |
| | | | | -100 | | $V_{GS}=-20 \text{ V}$ |
| Drain-source leakage current | I_{DSS} | | | 1 | μA | $V_{DS}=100 \text{ V}, V_{GS}=0 \text{ V}$ |
| Gate resistance | R_G | | 4.9 | | Ω | $f=1 \text{ MHz}, \text{Open drain}$ |

Dynamic Characteristics

| Parameter | Symbol | Min. | Typ. | Max. | Unit | Test condition |
|------------------------------|---------------------|------|------|------|------|--------------------------------------------------------------------------------------------------|
| Input capacitance | C _{iss} | | 6850 | | pF | V _{GS} =0 V, V _{DS} =25 V, f=100 kHz |
| Output capacitance | C _{oss} | | 3170 | | pF | |
| Reverse transfer capacitance | C _{rss} | | 251 | | pF | |
| Turn-on delay time | t _{d(on)} | | 32 | | ns | V _{GS} =10 V, V _{DS} =50 V, R _G =2 Ω, I _D =65 A |
| Rise time | t _r | | 138 | | ns | |
| Turn-off delay time | t _{d(off)} | | 88 | | ns | |
| Fall time | t _f | | 106 | | ns | |

Gate Charge Characteristics

| Parameter | Symbol | Min. | Typ. | Max. | Unit | Test condition |
|----------------------|----------------------|------|------|------|------|--------------------------------------------------------------------------|
| Total gate charge | Q _g | | 87.8 | | nC | V _{GS} =10 V, V _{DS} =50 V, I _D =65 A |
| Gate-source charge | Q _{gs} | | 27.1 | | nC | |
| Gate-drain charge | Q _{gd} | | 22.9 | | nC | |
| Gate plateau voltage | V _{plateau} | | 5.5 | | V | |

Body Diode Characteristics

| Parameter | Symbol | Min. | Typ. | Max. | Unit | Test condition |
|-------------------------------|------------------|------|------|------|------|------------------------------------------------------------------|
| Diode forward voltage | V _{SD} | | | 1.3 | V | I _S =30 A, V _{GS} =0 V |
| Reverse recovery time | t _{rr} | | 158 | | ns | V _R =50 V, I _S =65 A, di/dt=100 A/μs |
| Reverse recovery charge | Q _{rr} | | 437 | | nC | |
| Peak reverse recovery current | I _{rrm} | | 5 | | A | |

Note

- 1) Calculated continuous current based on maximum allowable junction temperature.
- 2) Repetitive rating; pulse width limited by max. junction temperature.
- 3) Pd is based on max. junction temperature, using junction-case thermal resistance.
- 4) The value of R_{θJA} is measured with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with T_a=25 °C.
- 5) V_{DD}=50 V, V_{GS}=10 V, L=0.3 mH, starting T_j=25 °C.

Electrical Characteristics Diagrams

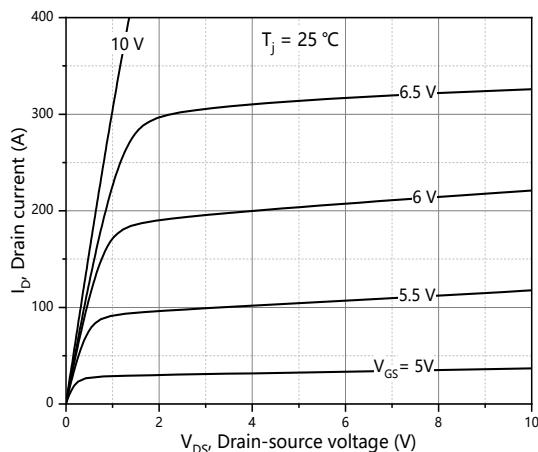


Figure 1. Typ. output characteristics

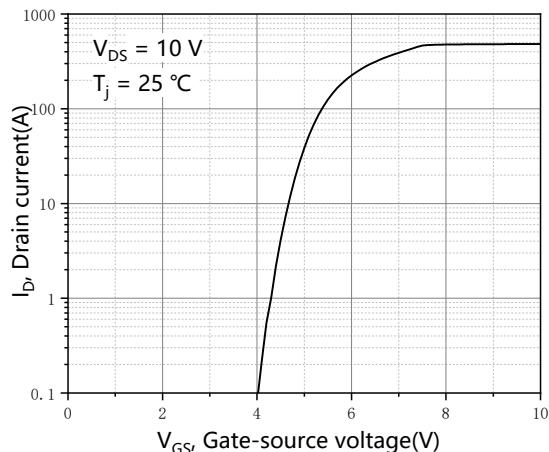


Figure 2. Typ. transfer characteristics

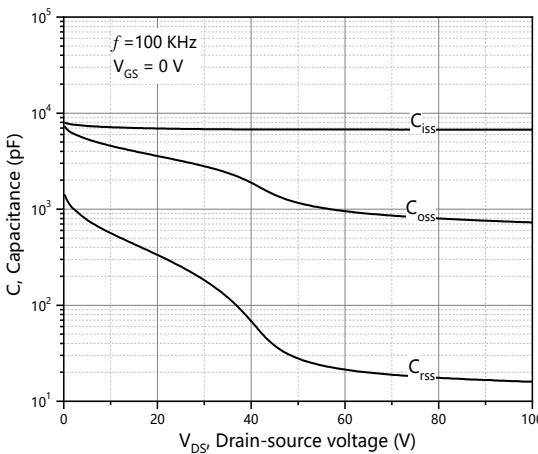


Figure 3. Typ. capacitances

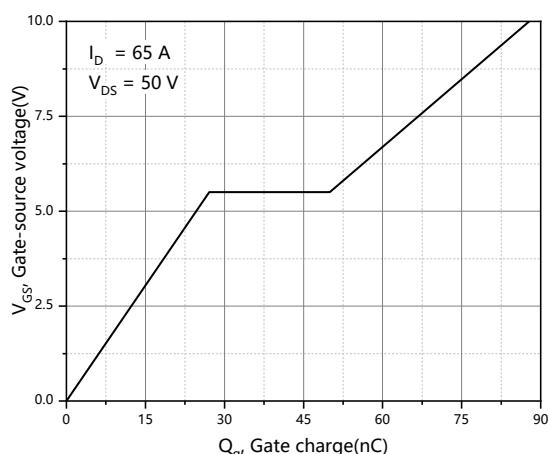


Figure 4. Typ. gate charge

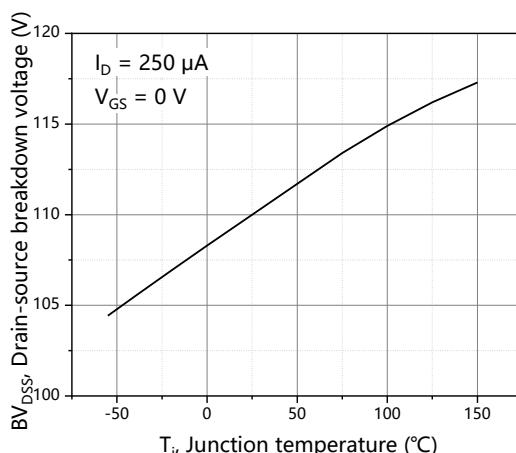


Figure 5. Drain-source breakdown voltage

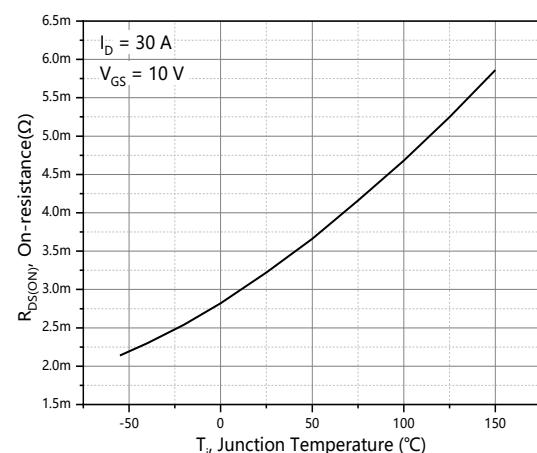


Figure 6. Drain-source on-state resistance

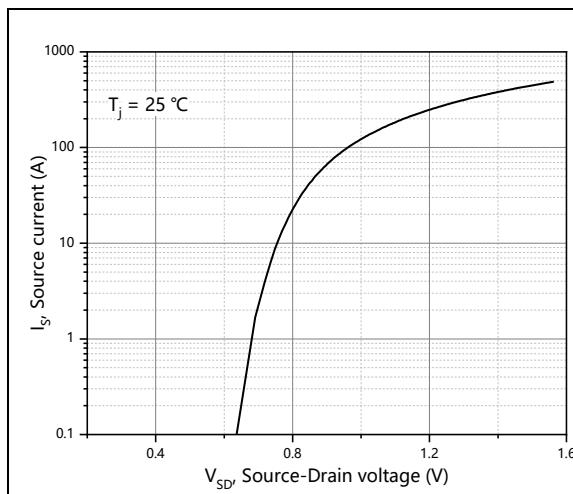


Figure 7. Forward characteristic of body diode

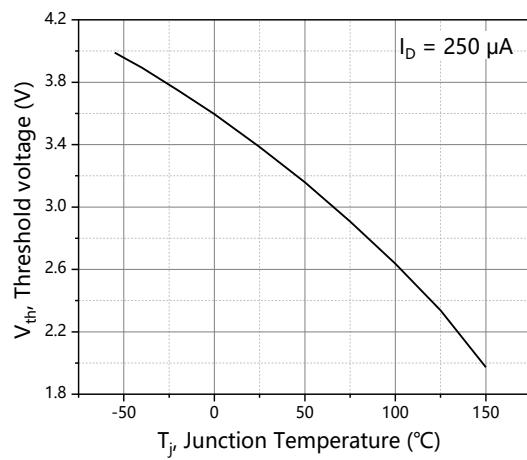


Figure 8. Threshold voltage

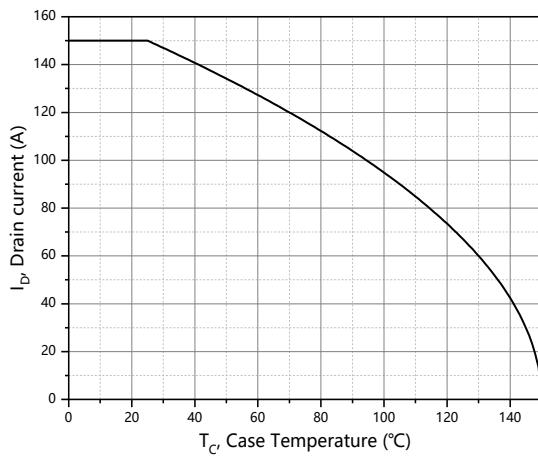


Figure 9. Drain current

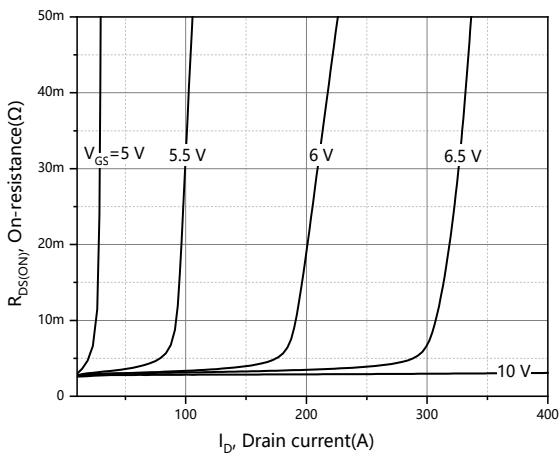


Figure 10. Drain-source on-state resistance

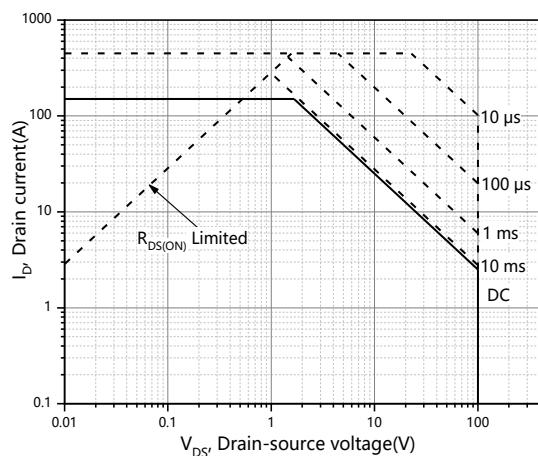


Figure 11. Safe operation area $T_C=25^\circ\text{C}$

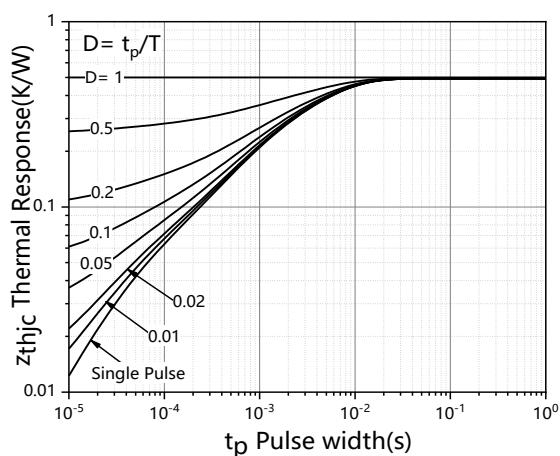


Figure 12. Max. transient thermal impedance

Test circuits and waveforms

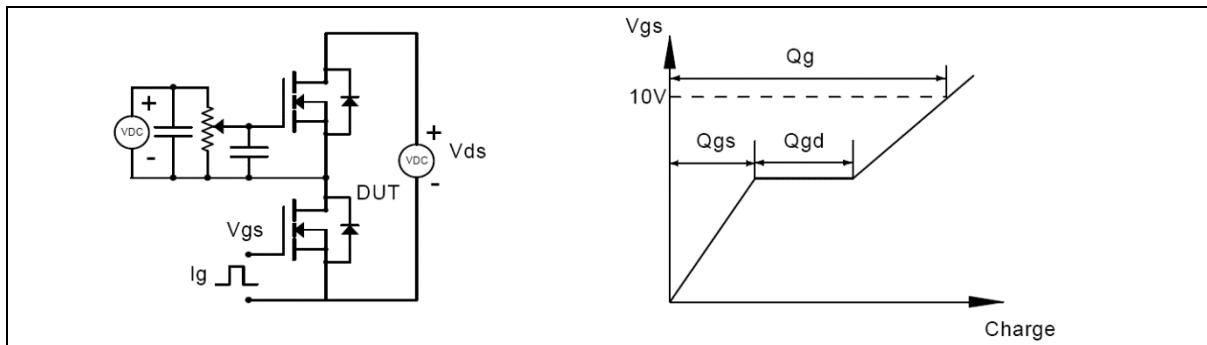


Figure 1. Gate charge test circuit & waveform



Figure 2. Switching time test circuit & waveforms



Figure 3. Unclamped inductive switching (UIS) test circuit & waveforms

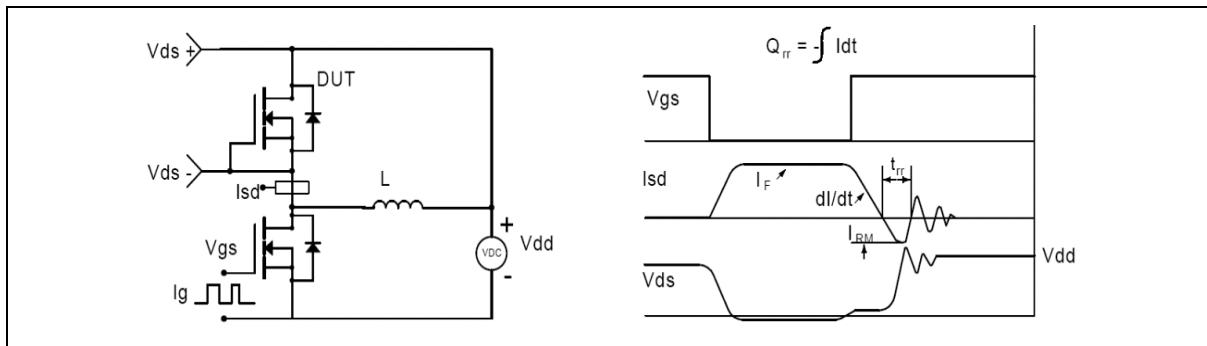
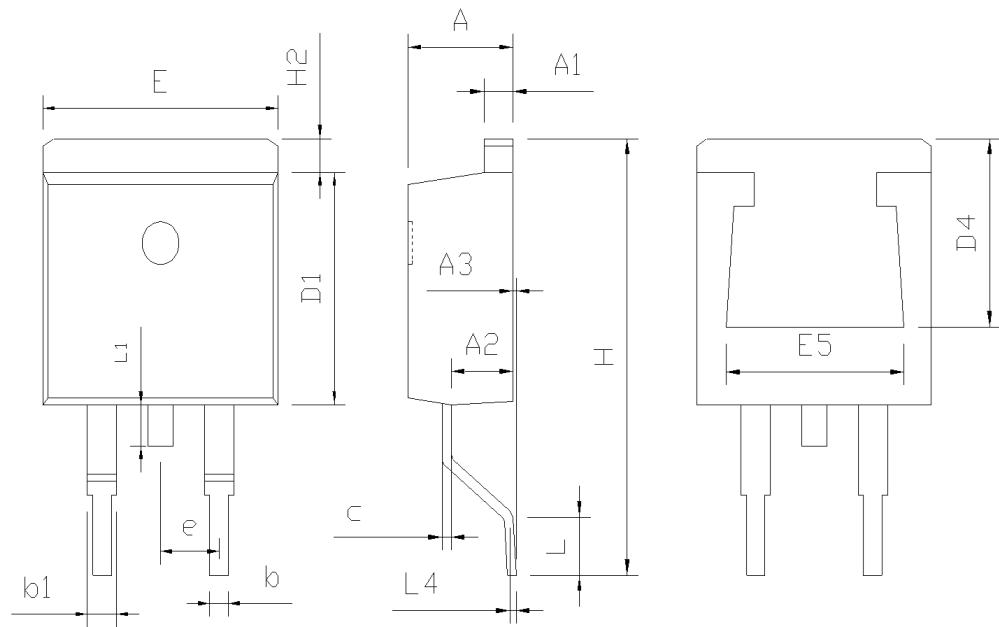


Figure 4. Diode reverse recovery test circuit & waveforms

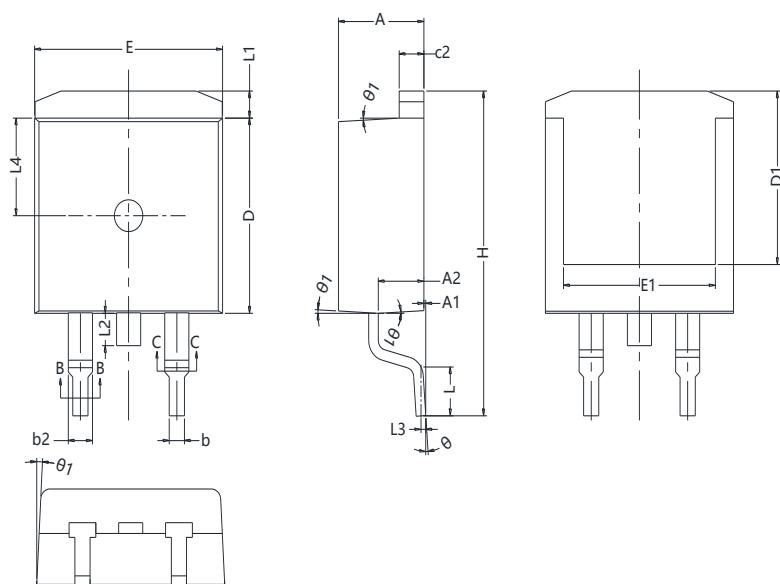
Package Information



| Symbol | mm | | |
|--------|----------|-------|-------|
| | Min | Nom | Max |
| A | 4.37 | 4.57 | 4.77 |
| A1 | 1.22 | 1.27 | 1.42 |
| A2 | 2.49 | 2.69 | 2.89 |
| A3 | 0.00 | 0.13 | 0.25 |
| b | 0.70 | 0.81 | 0.96 |
| b1 | 0.17 | 1.27 | 1.47 |
| c | 0.30 | 0.38 | 0.53 |
| D1 | 8.50 | 8.70 | 8.90 |
| D4 | 6.60 | - | - |
| E | 9.86 | 10.16 | 10.36 |
| E5 | 7.06 | - | - |
| e | 2.54 BSC | | |
| H | 14.70 | 15.10 | 15.50 |
| H2 | 1.07 | 1.27 | 1.47 |
| L2 | 2.00 | 2.30 | 2.60 |
| L1 | 1.40 | 1.55 | 1.70 |
| L4 | 0.25 BSC | | |

Version 1: TO263-C package outline dimension

Package Information



| Symbol | mm | | |
|--------|----------|-------|-------|
| | Min | Nom | Max |
| A | 4.40 | 4.50 | 4.60 |
| A1 | 0.00 | 0.10 | 0.25 |
| A2 | 2.20 | 2.40 | 2.60 |
| b | 0.76 | - | 0.89 |
| b1 | 0.75 | 0.80 | 0.85 |
| b2 | 1.23 | - | 1.37 |
| b3 | 1.22 | 1.27 | 1.32 |
| c | 0.47 | - | 0.60 |
| c1 | 0.46 | 0.51 | 0.56 |
| c2 | 1.25 | 1.30 | 1.35 |
| D | 9.10 | 9.20 | 9.30 |
| D1 | 8.00 | - | - |
| E | 9.80 | 9.90 | 10.00 |
| E1 | 7.80 | - | - |
| e | 2.54 BSC | | |
| H | 14.90 | 15.30 | 15.70 |
| L | 2.00 | 2.30 | 2.60 |
| L1 | 1.17 | 1.27 | 1.40 |
| L2 | - | - | 1.75 |
| L3 | 0.25 BSC | | |
| L4 | 4.60 REF | | |
| θ | 0° | - | 8° |
| θ1 | 1° | 3° | 5° |

Version 2: TO263-J package outline dimension

Ordering Information

| Package Type | Units/Reel | Reels / Inner Box | Units/Inner Box | Inner Boxes/Carton Box | Units/Carton Box |
|--------------|------------|-------------------|-----------------|------------------------|------------------|
| TO263-C | 800 | 1 | 800 | 5 | 4000 |
| TO263-J | 800 | 1 | 800 | 10 | 8000 |

Product Information

| Product | Package | Pb Free | RoHS | Halogen Free |
|-------------|---------|---------|------|--------------|
| SFG150N10KF | TO263 | yes | yes | yes |

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